

DEVICE TECHNOLOGY

Electrical suppression of all nonradiative recombination pathways in monolayer semiconductors

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Defects in conventional semiconductors substantially lower the photoluminescence (PL) quantum yield (QY), a key metric of optoelectronic performance that directly dictates the maximum device efficiency. Two-dimensional transition-metal dichalcogenides (TMDCs), such as monolayer MoS₂, often exhibit low PL QY for as-processed samples, which has typically been attributed to a large native defect density. We show that the PL QY of as-processed MoS₂ and WS₂ monolayers reaches near-unity when they are made intrinsic through electrostatic doping, without any chemical passivation. Surprisingly, neutral exciton recombination is entirely radiative even in the presence of a high native defect density. This finding enables TMDC monolayers for optoelectronic device applications as the stringent requirement of low defect density is eased.

Multiparticle Coulomb interactions are particularly pronounced in transition-metal dichalcogenide (TMDC) monolayers, leading to a multitude of recombination pathways, each associated with the different quasiparticles produced by these interactions (1). The recombination rate of excitons formed by photogenerated carriers (2, 3) depends nonlinearly on the concentration. Because excitons interact with background charge to form trions (4–8), the Fermi level also controls the dominant recombination pathway. Thus, both the background carrier concentration and the generation rate must be tuned to investigate the complete effect of multiparticle interactions on TMDC photoluminescence (PL) quantum yield (QY).

In this work, we simultaneously altered the photocarrier generation rate (G) by varying the incident pump power and altered the total charge concentration (electron and hole population densities; N and P , respectively) by varying the back-gate voltage (V_g) in a capacitor structure (Fig. 1A). Surprisingly, we found that all neutral excitons recombine radiatively in as-processed monolayers of MoS₂, resulting in near-unity QY at low generation rates. This high QY occurred despite a reported high native defect density of 10^{10} to 10^{13} cm⁻² determined with microscopy techniques (9), which is in stark contrast to conventional inorganic semiconductors, where even a small number of defects has detrimental effects on the PL QY (10). To gain additional insight into the photophysics, we also introduce a simple kinetic

model that involves excitons, trions, biexcitons, and free carriers for both sulfur- and selenide-based TMDCs. We previously demonstrated that bis(trifluoromethane) sulfonimide (TFSI) treatment results in near-unity PL QY in monolayer MoS₂ (11). However, the underlying mechanism remained unknown. Here, we show that the PL enhancement mechanism is electron counter-doping without chemical defect passivation; TFSI effectively acts as a Lewis acid. Beyond solving that mystery, the work here presents a practical

method of brightening TMDCs for device applications, overcoming TFSI's major limitation of stability during subsequent device processing.

We first present data from a MoS₂ device, which contained a monolayer of MoS₂ encapsulated in poly(methyl methacrylate) (PMMA), along with a transferred gold electrical contact (12). PMMA reduced V_g hysteresis (13, 14), thus enabling more stable and accurate measurements (fig. S1). (Device fabrication details are available in the supplementary materials.) The V_g dependence of the PL spectra of a MoS₂ monolayer was measured at a high generation rate of $G = 10^{18}$ cm⁻² s⁻¹ (Fig. 1B). The peak PL intensity at $V_g = -20$ V showed a ~300-fold enhancement compared with $V_g = 0$ V (Fig. 1B). A peak energy shift of 30 meV was also observed (Fig. 1B, inset; a detailed discussion of peak position is provided in the supplementary materials and fig. S2), which has been attributed to the trion binding energy (5–8, 15). PL images of a monolayer device showed that the enhancement of PL intensity through electrostatic doping was spatially uniform (Fig. 1, C, D, and E). Calibrated PL measurements at room temperature were performed to quantitatively extract the QY as a function of V_g and G (Fig. 2, A and B; measurement accuracy and precision are discussed in the supplementary materials). At $V_g = 0$ V and $G = 6 \times 10^{17}$ cm⁻² s⁻¹, the QY was 0.1% (Fig. 2B), which is consistent with the pristine MoS₂ in previous reports (11, 16). The QY increased as V_g decreased; at $V_g = -20$ V and a low generation rate of $G = 6 \times 10^{15}$ cm⁻² s⁻¹, the QY increased by three orders of magnitude and reached a peak value of $75 \pm 10\%$ (an expanded figure of Fig. 2B is shown in fig. S3). Through

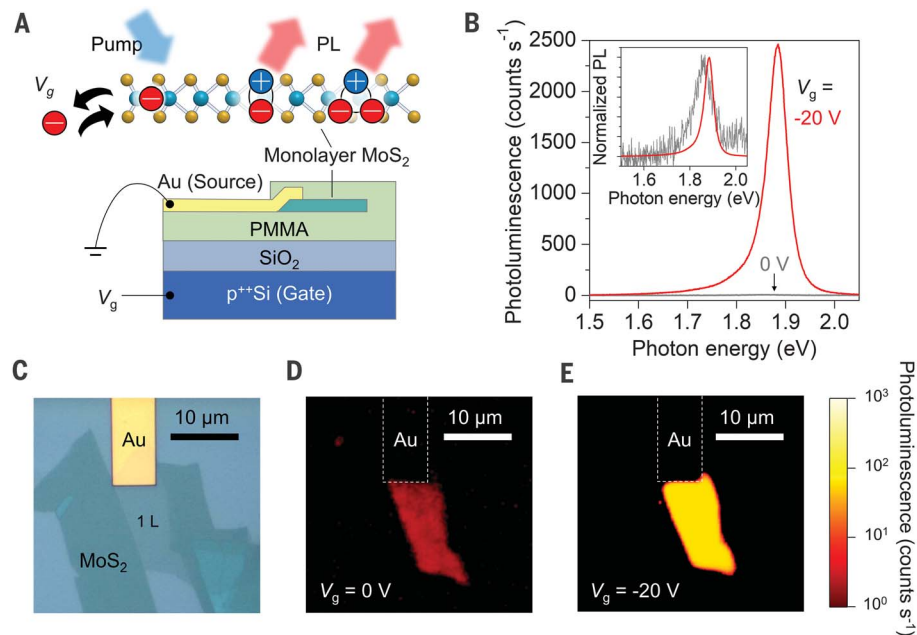


Fig. 1. Schematics of the device and the gate dependence of photoluminescence in MoS₂.

(A) Schematic showing control of different quasiparticles by gate voltage V_g and generation rate G . (B) PL spectra of the MoS₂ monolayer device under gate voltages $V_g = -20$ and 0 V at generation rate $G = 10^{18}$ cm⁻² s⁻¹. (Inset) The normalized PL spectra. (C) Top-view optical micrograph of a MoS₂ device. (D and E) PL imaging of the device at (D) $V_g = 0$ V and (E) $V_g = -20$ V.

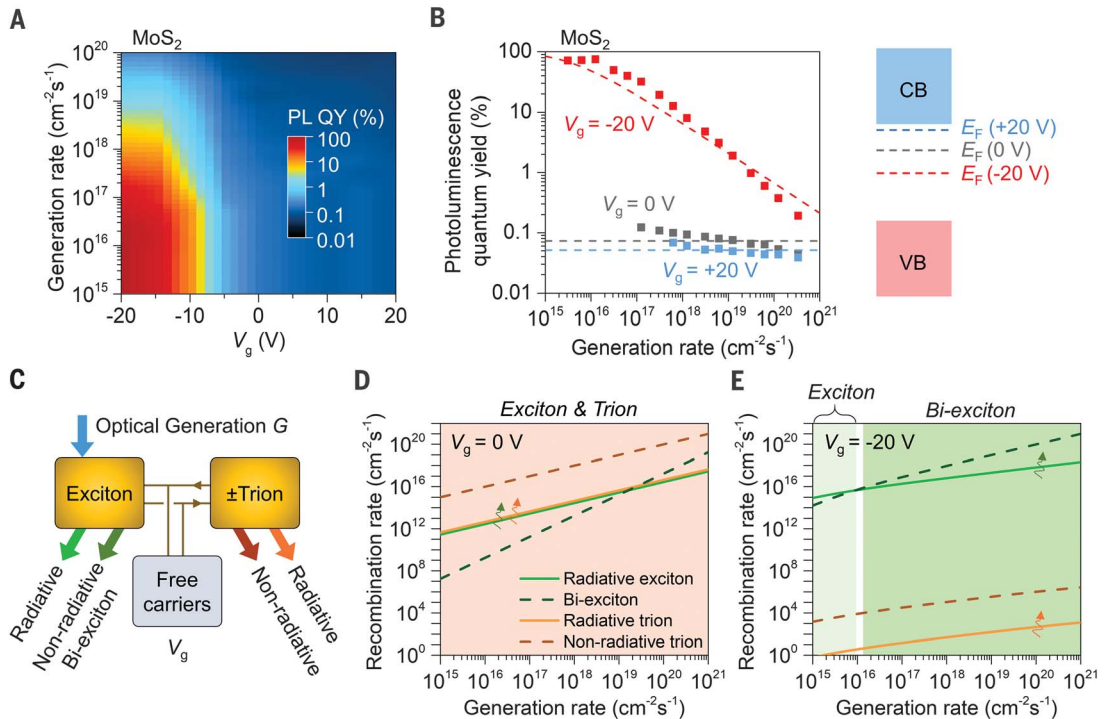
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Fig. 2. Near-unity PL QY in MoS₂ through electrostatic doping compensation.

(A) A color plot of MoS₂ PL QY versus G and V_g . (B) The MoS₂ PL QY versus G at $V_g = +20, 0,$ and -20 V. Points, experimental data; dashed lines, model. (Right) Illustration of Fermi level position for different V_g . (C) Exciton and trion recombination pathways in TMDC materials. (D and E) Calculated radiative and nonradiative recombination rates of excitons and trions in MoS₂ at (D) $V_g = 0$ V and (E) $V_g = -20$ V.



application of V_g , the QY of a chemically untreated MoS₂ monolayer approached unity ($75\% \pm 10\%$), matching the response previously observed in MoS₂ monolayers treated with TFSI (11).

In the traditional ABC model (17) of carrier recombination in semiconductors, defect-mediated Shockley-Read-Hall (SRH) recombination dominates at low generation rates, whereas Auger recombination dominates at high generation. In the SRH regime, QY increases linearly with G . In the Auger regime, QY decreases with a slope of $-2/3$ in a log-log plot (17). Neither of these power laws were observed in the pump-dependent QY behavior of MoS₂. Instead, the observed response can be understood by considering the interaction of excitons, trions, and free carriers and their subsequent recombination channels (shown schematically in Fig. 2C; details are available in the supplementary materials). Depending on the type of carriers present, the evolution of the exciton formed by photogenerated carriers varies dramatically. If the semiconductor is intrinsic, the exciton stays neutral; if the majority charge carriers are holes or electrons, the exciton may become a positive or negative trion, respectively. For the case with negative trions, the generation rate G in steady state is balanced by the rates of all of the recombination channels

$$G = \frac{n_X}{\tau_X} + \frac{n_T}{\tau_T} + C_{bx}n_X^2 \quad (1)$$

where n_X and n_T are the neutral exciton and negative trion population densities, respectively; τ_X and τ_T are the neutral exciton and negative trion lifetimes, respectively; and C_{bx} is the bi-exciton annihilation coefficient (11, 18, 19). The exciton and trion lifetimes have radiative (τ_{Xr} , τ_{Tr}) and nonradiative (τ_{Xnr} , τ_{Trnr}) components:

$\frac{1}{\tau_X} = \frac{1}{\tau_{Xr}} + \frac{1}{\tau_{Xnr}}$, $\frac{1}{\tau_T} = \frac{1}{\tau_{Tr}} + \frac{1}{\tau_{Trnr}}$. The QY is then given by the ratio of the radiative recombination rate of both trions and excitons to total generation rate G

$$QY = \frac{G}{G} \left(\frac{n_{Xr}}{\tau_{Xr}} + \frac{n_{Tr}}{\tau_{Tr}} \right) \quad (2)$$

The total negative charge concentration in the monolayer is given by $N = C_{ox}(V_g - V_{th})/q$, where C_{ox} is the gate-oxide capacitance, q is the electronic charge, and V_{th} is the threshold voltage. $N = n_e + n_T$, as this negative charge density arises from negative trions (n_T) or free electrons (n_e). The trion formation and dissociation rates balance in steady state and yield a law of mass-action $n_T = Tn_Xn_e$, where T is the trion formation coefficient (6, 20). Combining these equations, the trion concentration can be written as a function of exciton concentration n_X

$$n_T = \frac{Tn_X}{1 + Tn_X}N \quad (3)$$

At low exciton density ($Tn_X \ll 1$), the trion and exciton densities are mutually proportional ($n_T \approx Tn_X$), but at high exciton density ($Tn_X \gg 1$), the trion concentration asymptotically approaches the background electron concentration ($n_T \approx N$). Numerically solving Eqs. 1 and 3 provided exciton and trion densities for any generation rate G and gate voltage V_g .

This model well describes the MoS₂ QY data shown in Fig. 2B. By fitting the experimental data to the model, we extracted $\tau_{Tr} = 110$ ns, $\tau_{Trnr} = 50$ ps, $\tau_{Xr} = 8$ ns, and $C_{bx} = 3.5$ cm² s⁻¹. Excitons are radiative, whereas trions and biexcitons are nonradiative. Specifically, the extracted trion nonradiative lifetime was nearly three orders of magnitude lower than the trion radiative lifetime,

implying that the dominant trion recombination pathway is nonradiative. This difference could be the result of a defect-assisted decay and/or a geminate Auger-like process in which the electron provides the third particle required for momentum conservation. The effective trion nonradiative lifetime τ_{Trnr} reflects the combined effects of these processes. Nonradiative Auger-like recombination of trions has also been identified in doped quantum dots (21). By contrast, the model does not require an exciton nonradiative lifetime to fit the data, highlighting that pure exciton recombination is entirely radiative. One possibility is that the tightly bound, charge-neutral excitons do not interact strongly with the native charged defects. This could be an inherent trait of all excitonic systems (such as quantum dots) because they generally exhibit high QY. At high exciton densities (high generation rates), nonradiative biexciton annihilation dominated. At a specific generation rate G , V_g changed the relative populations of excitons and trions, resulting in different recombination pathways dominating (Fig. 2, D and E).

As-exfoliated monolayer MoS₂ is electron-rich because of donor-like chalcogenide vacancies, placing the Fermi level near the conduction band (22). Thus, for $V_g \geq 0$ V, the trion nonradiative recombination rate dominated for all G , resulting in the low observed QY (Fig. 2D). However, by applying negative V_g , the background electron concentration was reduced, and the majority of the quasiparticles were neutral excitons (fig. S4). This change is validated by the spectral shift (Fig. 2B and fig. S2). In this regime, the exciton radiative recombination rate dominated (Fig. 2E), and the observed QY was near unity ($75\% \pm 10\%$) at low generation rates. At high

generation rates, the exciton recombination rate varied as $G^{0.5}$ because of biexciton annihilation (Fig. 2E). This causes a drop in the QY (Fig. 2B).

We also studied the V_g and G dependence of PL QY for monolayers of WS_2 , WSe_2 , and $MoSe_2$. The same model accurately describes these TMDCs (table S1). Similar to MoS_2 , WS_2 monolayers are inherently n-doped because of sulfur vacancies and reach near-unity QY ($\sim 90\%$) at $V_g = -20$ V (fig. S5) (23). By contrast, WSe_2 and $MoSe_2$ are nearly intrinsic at $V_g = 0$ V (Fig. 3, A and B, and fig. S6, $MoSe_2$ data). Thus, exciton radiative recombination dominated at near-zero V_g and low

G , resulting in the highest measured QY of $\sim 8\%$ (Fig. 3C). Positive and negative V_g moved the Fermi level closer to the conduction band and the valence band, respectively (Fig. 3B). At $V_g = +20$ and -20 V, the negative and positive trion nonradiative recombination rates dominated, respectively, lowering the QY. At $V_g = -20$ V, the QY increased with G from $10^{16} < G < 10^{19}$ $cm^{-2}s^{-1}$. This unusual response is also well explained by our model. Specifically, at $G = 10^{18}$ $cm^{-2}s^{-1}$, the trion concentration saturated to the total charge concentration, beyond which excess excitons could not form trions (fig. S7). The neutral exci-

ton recombination pathway then dominated, increasing the QY until biexciton annihilation dominated (Fig. 3D). Last, unlike sulfur-based TMDCs, selenide-based TMDCs did not achieve near-unity QY even when their Fermi levels are near mid-gap. The reason could either be the presence of an indirect band gap near the direct band gap (24, 25) or dark excitons (26).

TFSI-treated monolayer MoS_2 was previously shown to exhibit near-unity PL QY, but the underlying enhancement mechanism was unclear (11, 16). Here, we show that the effect of the treatment is electron counterdoping, justified by means of both PL QY and time-resolved PL (TRPL) measurements. TFSI-treated MoS_2 and an untreated sample at $V_g = -20$ V had similar PL QY, over five orders of magnitude variation in G (Fig. 4A). They also had comparable TRPL decay at a low pump fluence of 1 $nJ\ cm^{-2}$, with respective lifetimes of 10.2 and 6.9 ns (Fig. 4B). Additionally, their TRPL lifetimes matched closely for all fluences (Fig. 4C and fig. S8). The Lewis acid nature of TFSI is well established in organic chemistry (27). Our results depict that TFSI acts as a Lewis acid by withdrawing electrons from (hole doping) TMDCs by means of surface charge transfer. This explanation was further validated by the observation of a threshold voltage shift in TMDC transistors after TFSI treatment, which is consistent with hole doping (fig. S9). Last, the reduction of PL QY in selenide-based TMDCs after TFSI treatment (16) is also consistent with the gated PL measurements and these materials being initially near intrinsic.

For the TMDCs we studied, the QYs were highest when the monolayers were intrinsic, implying that all neutral excitons radiatively recombine even in the presence of native defects. Although near-unity QY is commonly observed in organic dye molecules (28), it is uncommon in conventional inorganic semiconductors. This work establishes TMDC monolayers for optoelectronics because they can exhibit near-unity PL QY without the stringent requirement for low defect density. This electrostatic PL enhancement scheme is simple and general enough to be applied to

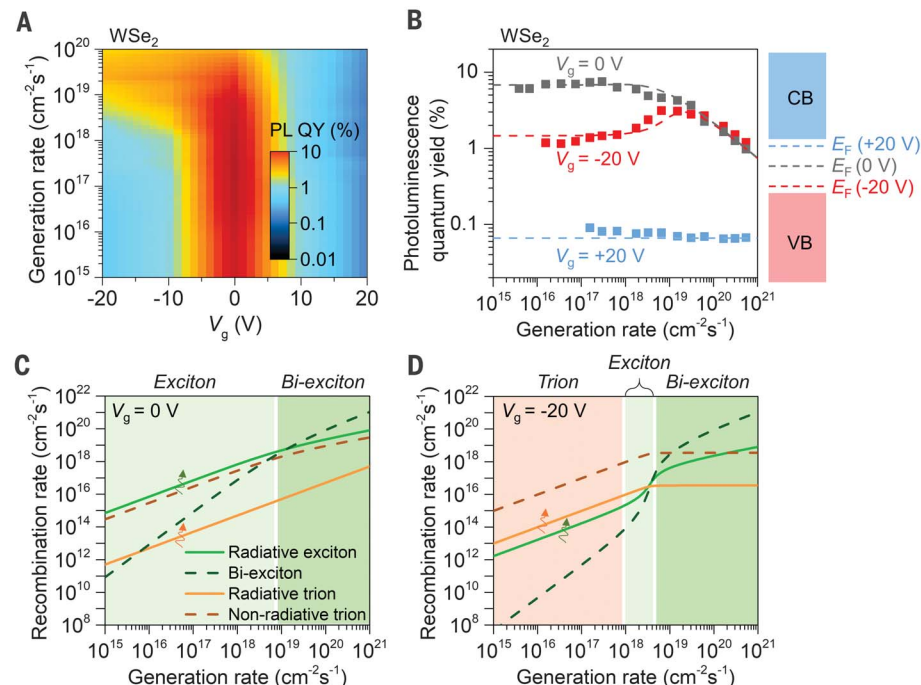


Fig. 3. PL QY versus generation rate in WSe_2 monolayers. (A) A color plot of PL QY versus G and V_g in WSe_2 . (B) The PL QY versus G at $V_g = +20$, 0 , and -20 V. Points, experimental data; dashed lines, model. (Right) Illustration of Fermi level position for different V_g . (C and D) Radiative and nonradiative recombination rates of excitons and trions in WSe_2 at (C) $V_g = 0$ V, and (D) $V_g = -20$ V. At $V_g = -20$ V, recombination rate shows the effect of positive trion saturation leading to the observed bump in (B).

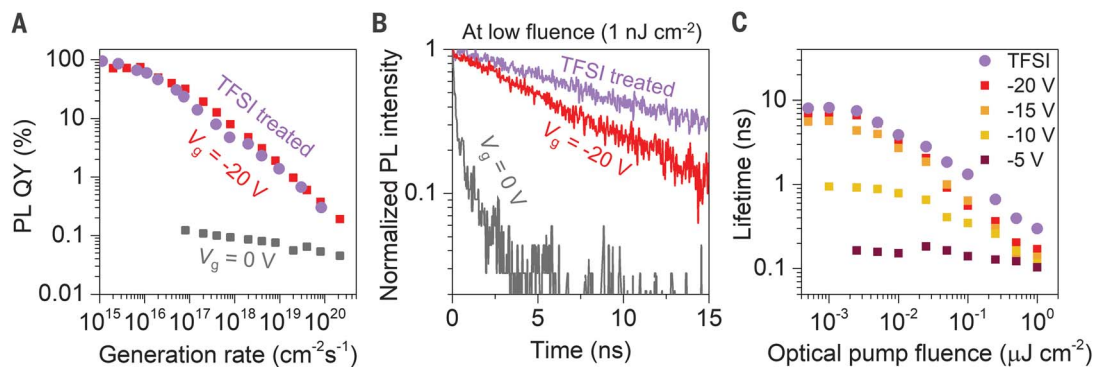


Fig. 4. Comparison of electrostatic doping and TFSI treatment. (A) QY versus G for TFSI-treated and electrostatically doped monolayer MoS_2 . (B) TRPL of a TFSI-treated MoS_2 (purple), and a MoS_2 device under $V_g = 0$ V (black) and $V_g = -20$ V (red) at pump fluence of 1 $nJ\ cm^{-2}$. (C) PL lifetime versus optical pump fluence for TFSI-treated MoS_2 and a MoS_2 device under various gate voltages V_g . Increasing V_g decreases TRPL lifetime because trions have a shorter lifetime than excitons. Increasing fluence decreases the lifetime through biexciton annihilation.

other excitonic systems without the need for material-specific passivation techniques.

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ACKNOWLEDGMENTS

Funding: Material preparation, optical characterizations, and modeling were supported by the U.S. Department of Energy, Office of Science, Office of Basic Energy Sciences, Materials Sciences and Engineering Division, under contract DE-AC02-05CH11231 within the Electronic Materials Program (KC1201). Device fabrication was supported by the Center for Energy Efficient Electronics Science (NSF award 0939514).

Author contributions: D.-H.L., S.Z.U., and A.J. conceived the idea for the project and designed the experiments. D.-H.L. and S.Z.U. performed optical measurements. S.Z.U., M.Y., H.K., and M.A. fabricated devices. D.-H.L., S.Z.U., and A.J. analyzed the data. S.Z.U. and E.Y. performed analytical modeling. J.W.A. helped design optical characterization and also discussed recombination model. D.-H.L., S.Z.U., M.Y., and A.J. wrote the manuscript. All authors discussed the results and commented on the manuscript. **Competing interests:** The authors declare no competing financial interests. **Data and materials availability:** All data needed to evaluate the conclusions in the paper are present in the paper or the supplementary materials. The materials that support the findings of this study are available from the corresponding author upon reasonable request.

SUPPLEMENTARY MATERIALS

science.sciencemag.org/content/364/6439/468/suppl/DC1
Materials and Methods
Supplementary Text
Figs. S1 to S12
Table S1
References (29, 30)

25 January 2019; accepted 8 April 2019
10.1126/science.aaw8053

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Science **364** (6439), 468-471.
DOI: 10.1126/science.aaw8053

Electrostatic doping boosts emission

Although monolayers of transition-metal dichalcogenides such as molybdenum disulfide (MoS_2) and tungsten disulfide (WS_2) should exhibit strong photoluminescence, in practice, defects in these materials can lead to very low quantum yields (less than 1%). Lien *et al.* show that as-formed MoS_2 and WS_2 monolayers encapsulated in poly(methyl methacrylate) can be electrostatically doped to achieve quantum yields near unity. Under these conditions, instead of charged trion species that recombine nonradiatively, only neutral excitons that recombine emissively form. These results help explain why coating these materials with certain Lewis acids also boosts the quantum yield.

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